

# KA311

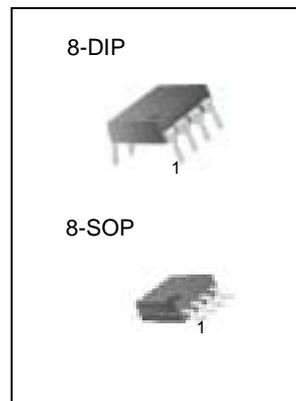
## Single Comparator

### Features

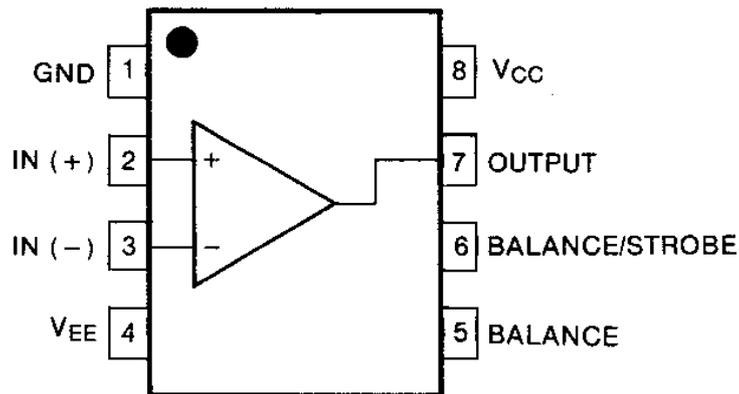
- Low input bias current : 250nA (Max)
- Low input offset current : 50nA (Max)
- Differential Input Voltage :  $\pm 30V$
- Power supply voltage : single 5.0V supply to  $\pm 15V$ .
- Offset voltage null capability.
- Strobe capability.

### Description

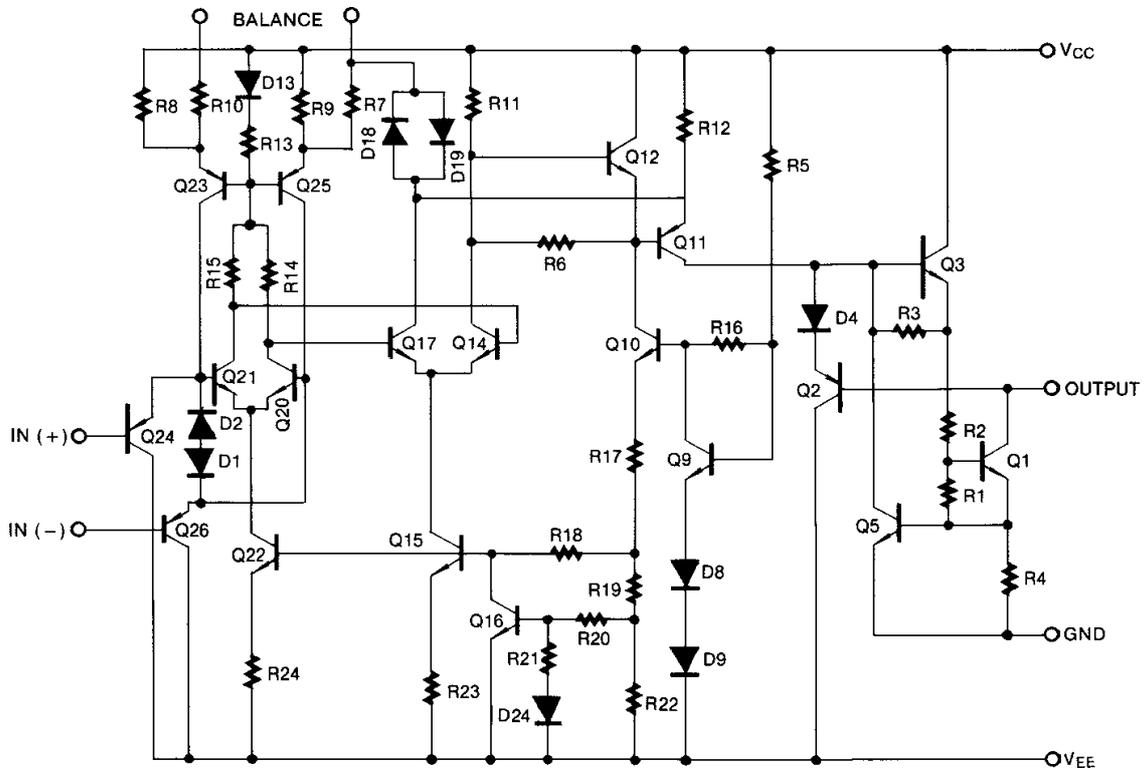
The KA311 series is a monolithic, low input current voltage comparator. The device is also designed to operate from dual or single supply voltage.



### Internal Block Diagram



## Schematic Diagram



## Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Total Supply Voltage	VCC	36	V
Output to Negative Supply Voltage KA311	VO - VEE	40	V
Ground to Negative voltage	VEE	-30	V
Differential Input Voltage	VI(DIFF)	30	V
Input Voltage	VI	±15	V
Output Short Circuit Duration	-	10	sec
Power Dissipation	PD	500	mW
Operating Temperature Range	TOPR	0 ~ +70	°C
Storage Temperature Range	TSTG	- 65 ~ +150	°C

## Electrical Characteristics

( $V_{CC} = 15V$ ,  $T_A = 25^\circ C$ , unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Units
Input Offset Voltage	$V_{IO}$	$R_S \leq 50K\Omega$	-	1.0	7.5	mV
			NOTE 1	-	-	
Input Offset Current	$I_{IO}$		-	6	50	nA
			NOTE 1	-	-	
Input Bias Current	$I_{BIAS}$		-	100	250	nA
			NOTE 1	-	-	
Voltage Gain	$G_V$	-	40	200	-	V/mV
Response Time	$t_{RES}$	NOTE 2	-	200	-	ns
Saturation Voltage	$V_{SAT}$	$I_O = 50mA$ , $V_I \leq -10mV$	-	0.75	1.5	V
		$V_{CC} \geq 4.5V$ , $V_{EE} = 0V$ $I_{SINK} = 8mA$ , $V_I \geq -10mV$ , NOTE 1	-	0.23	0.4	
Strobe "NO" Current	$I_{STR(ON)}$	-	-	3	-	mA
Output Leakage Current	$I_{SINK}$	$I_{STR} = 3mA$ , $V_I \geq 10mV$ $V_{O(P)} = 35V$ , $V_{EE} = V_{GND} = -5V$	-	0.2	50	nA
Input Voltage Range	$V_{I(R)}$	NOTE 1	-14.5 to 13.0	-14.7 to 13.8	-	V
Positive Supply Current	$I_{CC}$	-	-	3.0	7.5	mA
Negative Supply Current	$I_{EE}$	-	-	-2.2	-5.0	mA
Strobe Current	$I_{STR}$	-	-	3	-	mA

### Notes :

- $0 \leq T_A \leq +70^\circ C$
- The response time specified is for a 100mV input step with 5mV over drive.

# Typical Performance Characteristics

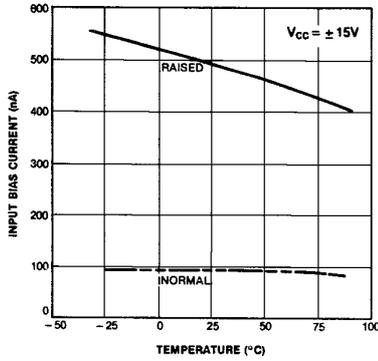


Figure 1. Input Bias Current Vs Temperature

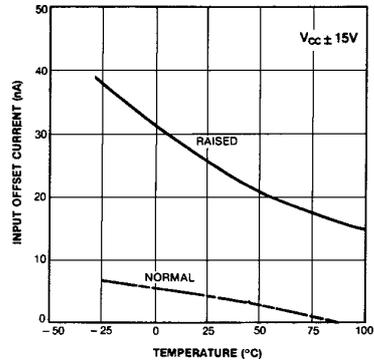


Figure 2. Input Offset Current Vs Temperature

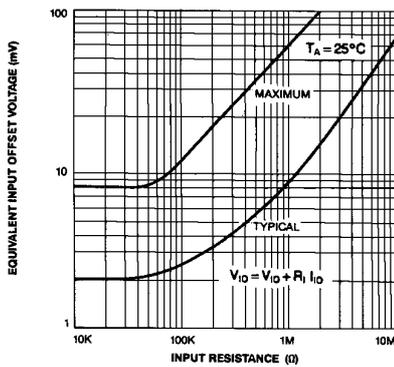


Figure 3. Offset Voltage vs Input Resistance

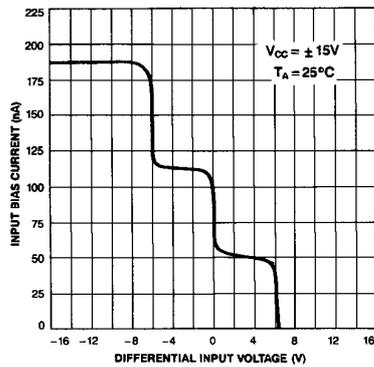


Figure 4. Input Bias Current vs Differential input voltage

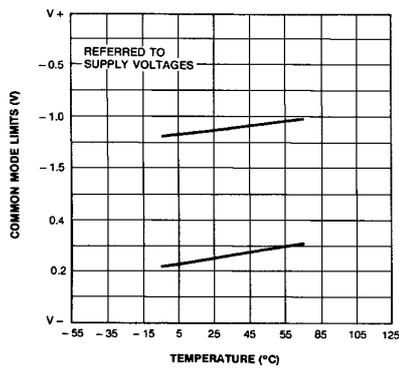


Figure 5. Common Mode Limits vs Temperature

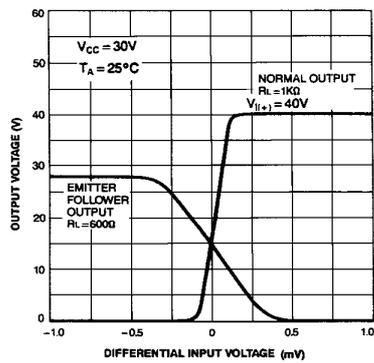


Figure 6. Output Voltage vs Differential input voltage

## Typical Performance Characteristics (continued)

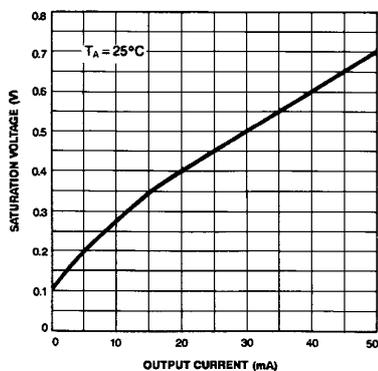


Figure 7. Saturation voltage vs Current

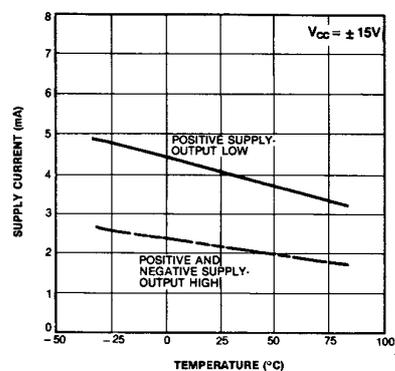


Figure 8. Supply Current vs Temperature

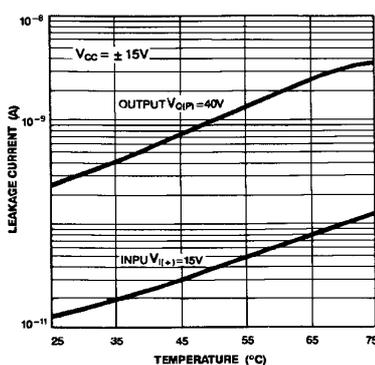


Figure 9. Leakage Current vs Temperature

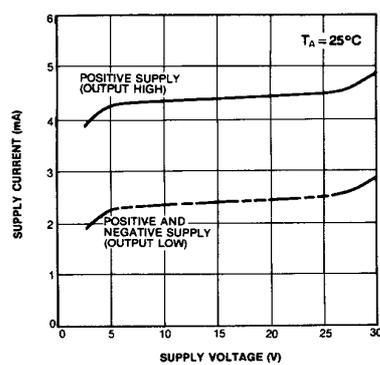


Figure 10. Supply Current vs Supply Voltage

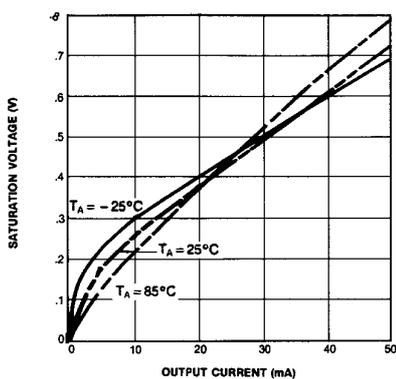


Figure 11. Current Saturation Voltage

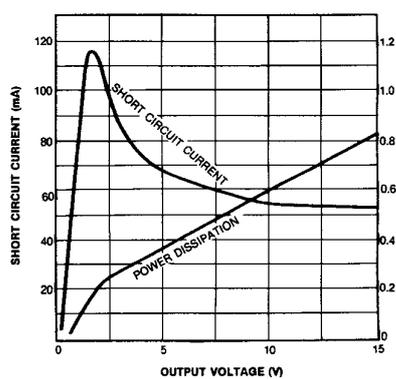
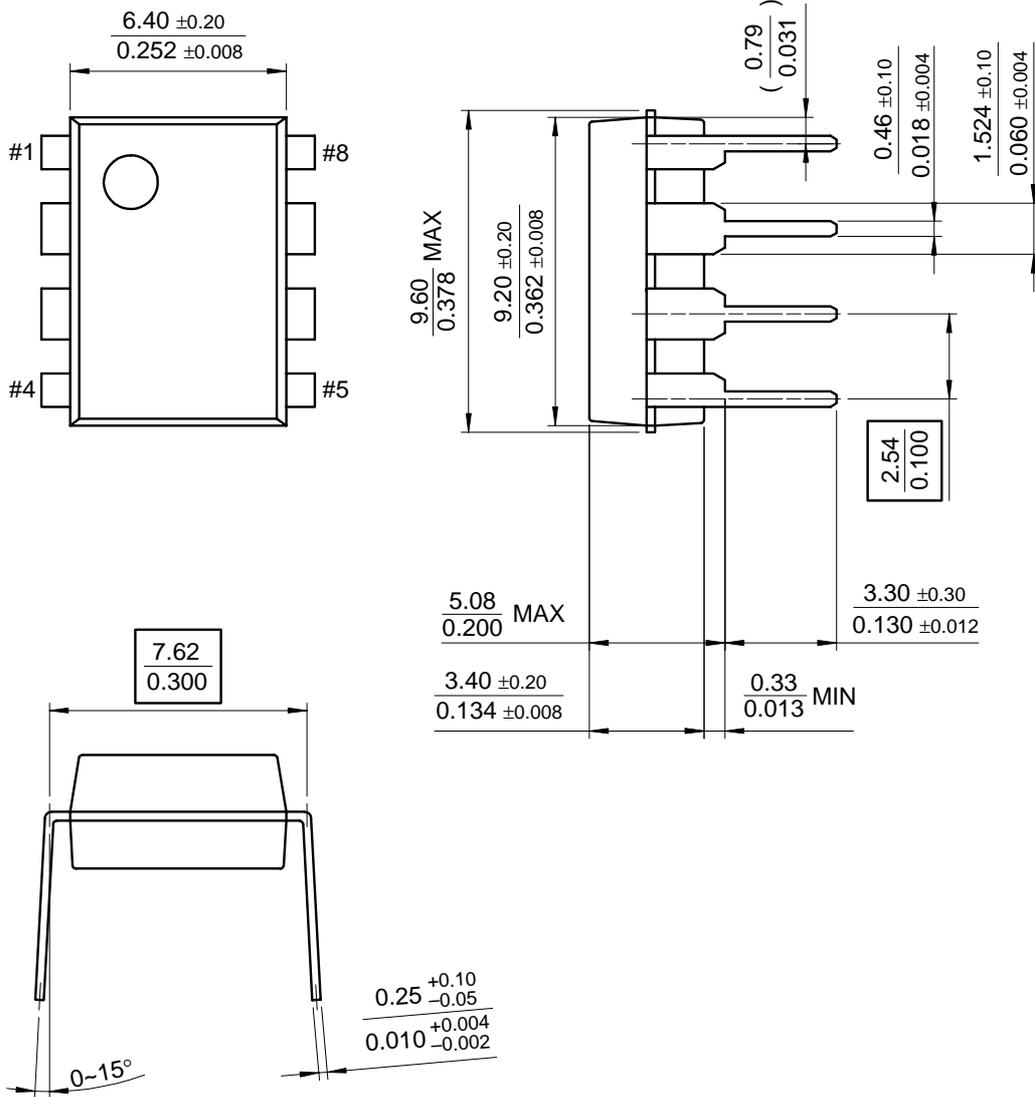


Figure 12. Output Limiting Characteristics

# Mechanical Dimensions

## Package

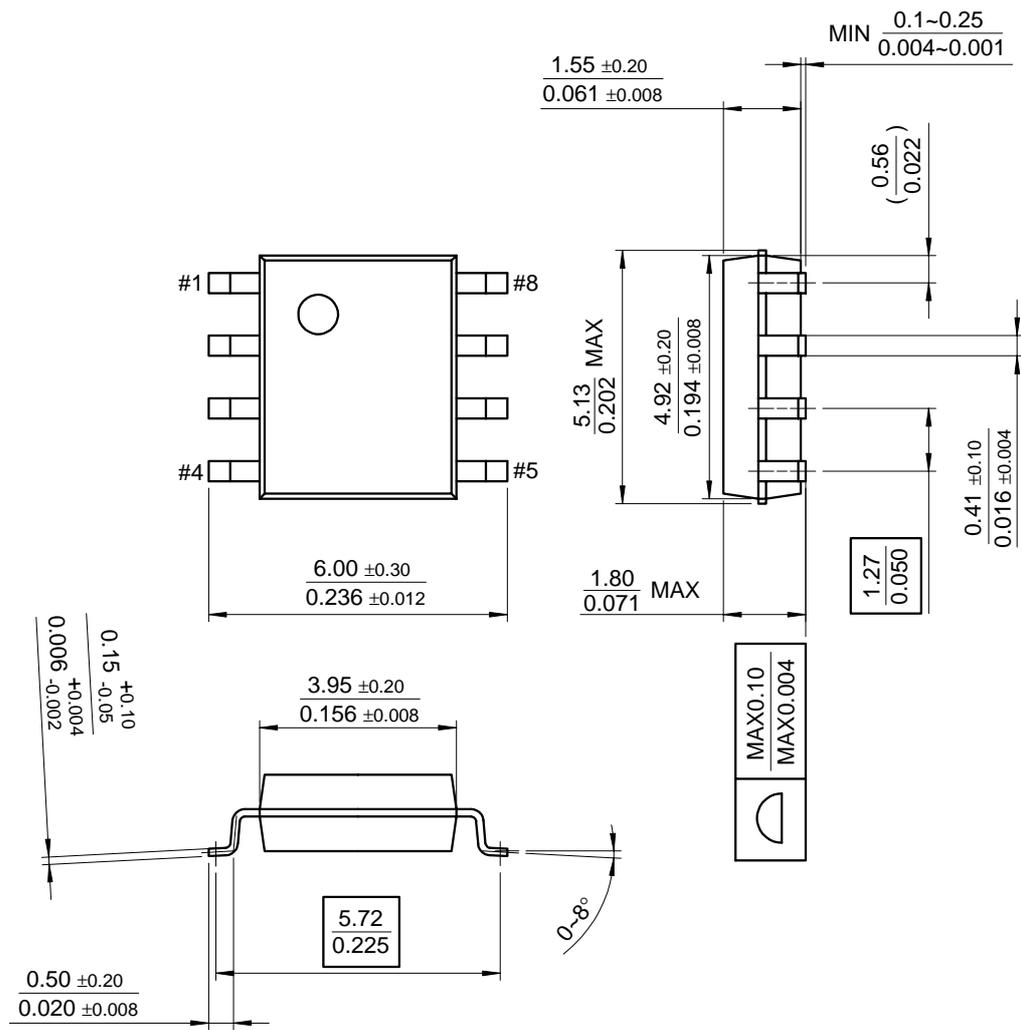
### 8-DIP



Mechanical Dimensions (Continued)

Package

8-SOP



**Ordering Information**

<b>Product Number</b>	<b>Package</b>	<b>Operating Temperature</b>
KA311	8-DIP	0 ~ +70°C
KA311D	8-SOP	



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